

March 2013

FDPF6N60ZUT

N-Channel UniFETTM Ultra FRFETTM MOSFET 600 V, 4.5 A, 2 Ω

Features

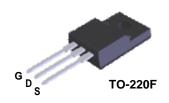
- $R_{DS(on)} = 1.7 \Omega (Typ.) @ V_{GS} = 10 V, I_D = 2.25 A$
- Low Gate Charge (Typ. 14.5 nC)
- Low C_{rss} (Typ. 5 pF)
- 100% Avalanche Tested
- Improved dv/dt Capability
- · RoHS Compliant

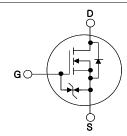
Applications

- LCD/LED TV
- Lighting
- · Uninterruptible Power Supply
- · AC-DC Power Supply

Description

UniFETTM MOSFET is Fairchild Semiconductor[®]s high voltage MOSFET family based on planar stripe and DMOS technology. This MOSFET is tailored to reduce on-state resistance, and to provide better switching performance and higher avalanche energy strength. UniFET Ultra FRFETTM MOSFET has much superior body diode reverse recovery performance. Its t_{rr} is less than 50nsec and the reverse dv/dt immunity is 20V/nsec while normal planar MOSFETs have over 200nsec and 4.5V/nsec respectively. Therefore UniFET Ultra FRFET MOSFET can remove additional component and improve system reliability in certain applications that require performance improvement of the MOSFET's body diode. This device family is suitable for switching power converter applications such as power factor correction (PFC), flat panel display (FPD) TV power, ATX and electronic lamp ballasts.





MOSFET Maximum Ratings $T_C = 25^{\circ}C$ unless otherwise noted*

Symbol		Parameter			Unit
V_{DSS}	Drain to Source Voltage			600	V
V_{GSS}	Gate to Source Voltage			±30	V
	Drain Current	- Continuous (T _C = 25°C)		4.5*	A
'D	Drain Current	- Continuous ($T_C = 100^{\circ}C$)		2.7*	A
I _{DM}	Drain Current	- Pulsed	(Note 1)	18*	А
E _{AS}	Single Pulsed Avalanche	Energy	(Note 2)	150	mJ
I _{AR}	Avalanche Current		(Note 1)	4.5	А
E _{AR}	Repetitive Avalanche Ene	ergy	(Note 1)	10.5	mJ
dv/dt	Peak Diode Recovery dv/	'dt	(Note 3)	20	V/ns
D	Dower Dissipation	(T _C = 25°C)		33.8	W
P_{D}	Power Dissipation	- Derate above 25°C		0.27	W/°C
T _J , T _{STG}	Operating and Storage Te	emperature Range		-55 to +150	°C
T _L	Maximum Lead Temperature for Soldering Purpose, 1/8" from Case for 5 Seconds			300	°C

^{*}Drain current limited by maximum junction temperature

Thermal Characteristics

Symbol	Parameter FDPF6N60ZUT		Unit
$R_{\theta JC}$	Thermal Resistance, Junction to Case, Max.	3.7	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient, Max. 62.5		C/VV

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDPF6N60ZUT	FDPF6N60ZUT	TO-220F	-	-	50

Electrical Characteristics $T_C = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
Off Charac	cteristics					
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \mu A$, $V_{GS} = 0 V$, $T_J = 25 ^{\circ} C$	600	-	-	V
ΔBV _{DSS} ΔΤ _J	Breakdown Voltage Temperature Coefficient	I _D = 250μA, Referenced to 25°C	-	0.75	-	V/°C
	Zero Gate Voltage Drain Current	$V_{DS} = 600V, V_{GS} = 0V$	-	-	25	
IDSS	Zero Gate voltage Drain Current	$V_{DS} = 480V, T_{C} = 125^{\circ}C$	-	-	250	μА
I _{GSS}	Gate to Body Leakage Current	$V_{GS} = \pm 30V, V_{DS} = 0V$	-	-	±10	μА

On Characteristics

$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 250 \mu A$	3.0	•	5.0	V
R _{DS(on)}	Static Drain to Source On Resistance	$V_{GS} = 10V, I_D = 2.25A$	-	1.7	2.0	Ω
9 _{FS}	Forward Transconductance	$V_{DS} = 40V, I_{D} = 2.25A$	-	3.5	ı	S

Dynamic Characteristics

C _{iss}	Input Capacitance	V 05V V 0V	-	650	865	pF
C _{oss}	Output Capacitance	$V_{DS} = 25V, V_{GS} = 0V$ f = 1MHz		75	100	pF
C _{rss}	Reverse Transfer Capacitance	1 - 11VII 12	-	5	10	pF
Q_g	Total Gate Charge at 10V		-	14.5	20	nC
Q_{gs}	Gate to Source Gate Charge	$V_{DS} = 480V, I_{D} = 4.5A$	-	4	-	nC
Q _{gd}	Gate to Drain "Miller" Charge	$V_{GS} = 10V$ (Note 4)	-	6	-	nC

Switching Characteristics

t _{d(on)}	Turn-On Delay Time			-	19	48	ns
t _r	Turn-On Rise Time	$V_{DD} = 300V, I_D = 4.5A$		-	25	60	ns
t _{d(off)}	Turn-Off Delay Time	$R_G = 25\Omega$, $V_{GS} = 10V$		-	25	60	ns
t _f	Turn-Off Fall Time		(Note 4)	-	45	100	ns

Drain-Source Diode Characteristics

I _S	Maximum Continuous Drain to Source Diode Forward Current			-	4.5	Α
I _{SM}	Maximum Pulsed Drain to Source Diode Forward Current		-	-	18	Α
V_{SD}	Drain to Source Diode Forward Voltage	V _{GS} = 0V, I _{SD} = 4.5A	-	-	1.6	V
t _{rr}	Reverse Recovery Time	V _{GS} = 0V, I _{SD} = 4.5A	-	36	-	ns
Q _{rr}	Reverse Recovery Charge	$dI_F/dt = 100A/\mu s$	-	37	-	nC

- **Notes:**1. Repetitive Rating: Pulse width limited by maximum junction temperature 2: L = 15mH, I_{AS} = 4.5A, V_{DD} = 50V, P_{C} = 25 Ω , Starting T_{J} = 25°C 3: I_{SD} ≤ 4.5A, di/dt ≤ 200A/ μ s, V_{DD} ≤ BV $_{DSS}$, Starting T_{J} = 25°C 4: Essentially Independent of Operating Temperature Typical Characteristics

Typical Performance Characteristics

Figure 1. On-Region Characteristics

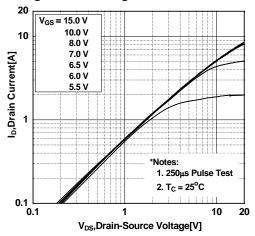


Figure 3. On-Resistance Variation vs.

Drain Current and Gate Voltage

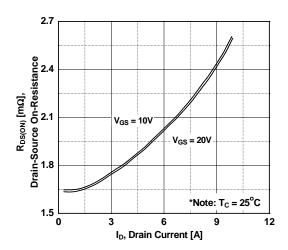


Figure 5. Capacitance Characteristics

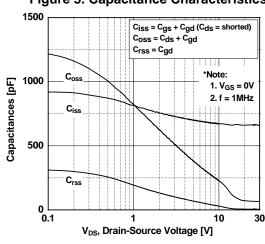


Figure 2. Transfer Characteristics

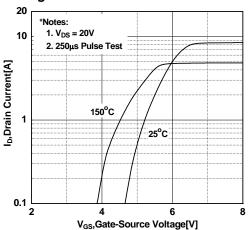


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

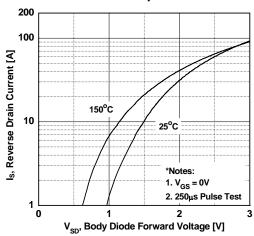
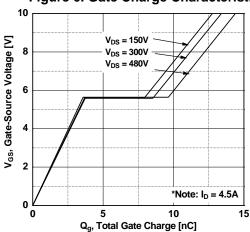


Figure 6. Gate Charge Characteristics



Typical Performance Characteristics (Continued)

Figure 7. Breakdown Voltage Variation vs. Temperature

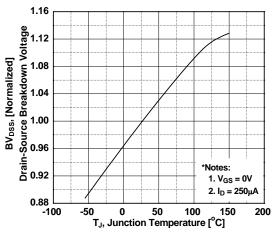


Figure 8. Maximum Safe Operating Area - FDPF6N60ZUT

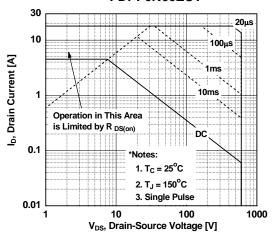


Figure 9. Maximum Drain Current vs. Case Temperature

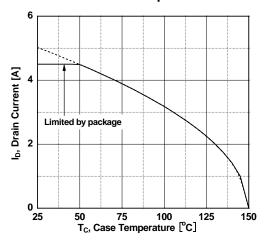
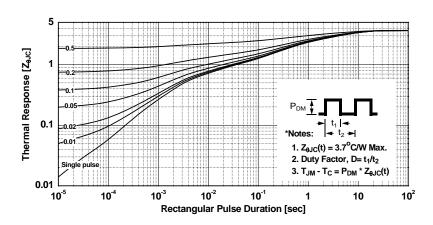
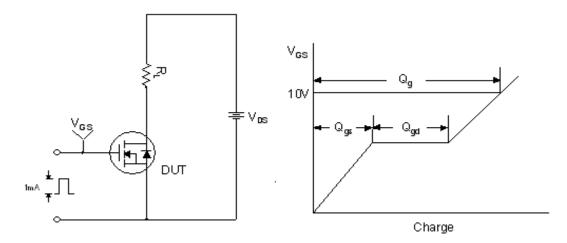


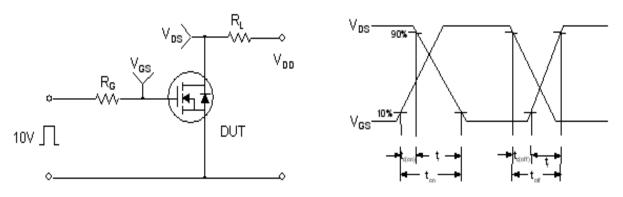
Figure 10. Transient Thermal Response Curve - FDPF6N60ZUT



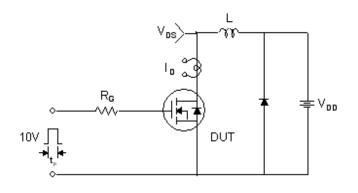
Gate Charge Test Circuit & Waveform

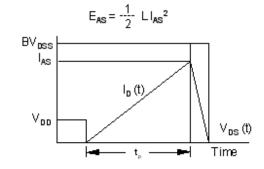


Resistive Switching Test Circuit & Waveforms

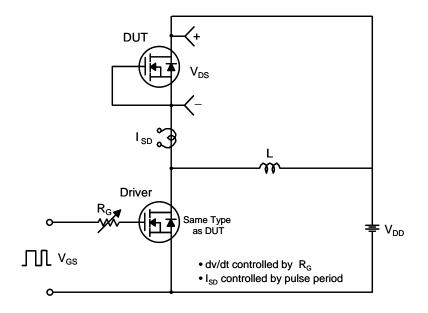


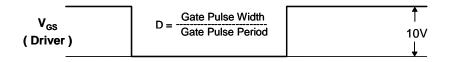
Unclamped Inductive Switching Test Circuit & Waveforms

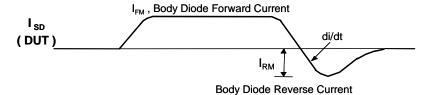




Peak Diode Recovery dv/dt Test Circuit & Waveforms







Body Diode Recovery dv/dt

V_{SD}

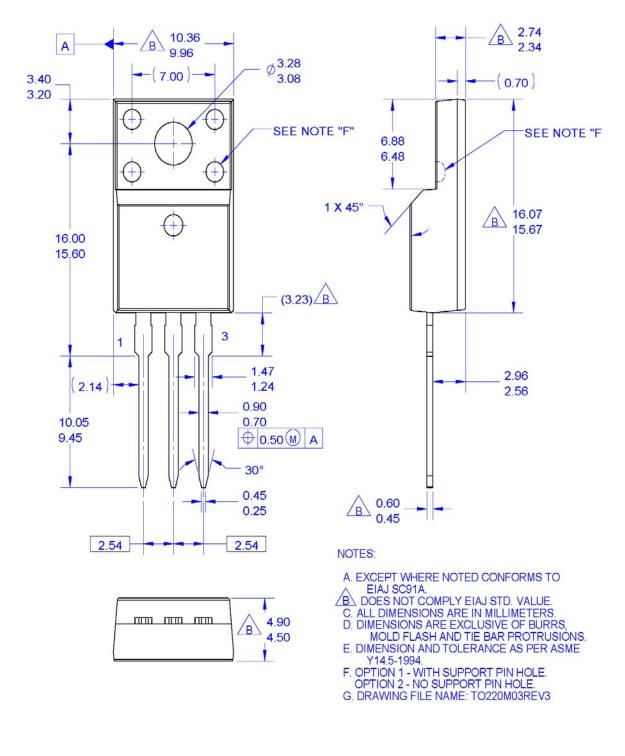
Body Diode

Body Diode

Forward Voltage Drop

Package Dimensions

TO-220M03







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